

**Search Notes**

Application/Control No.

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Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under  
Reexamination

EGBERT ET AL.

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner
340	572.7	8/11/2006	JAT
	572.1	8/11/2006	JAT
	572.4	8/11/2006	JAT
	572.5	8/11/2006	JAT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR